



HAOPIN MICROELECTRONICS CO.,LTD.

Description

Glass passivated, sensitive gate thyristors in a plastic envelope, intended for use in general purpose switching and phase control applications. These devices are intended to be interfaced directly to microcontrollers, logic integrated circuits and other low power gate trigger circuits.

Symbol		Simplified outline	
		 TO-252	
Pin	Description		
1	Cathode		
2	anode		
3	gate		
TAB	anode		

Applications:

- ◆ Motor control
- ◆ Industrial and domestic lighting
- ◆ Heating
- ◆ Static switching

Features

- ◆ Blocking voltage to 800 V
- ◆ On-state RMS current to 8 A
- ◆ Ultra low gate trigger current

SYMBOL	PARAMETER	Value	Unit
V_{DRM}	Repetitive peak off-state voltages	600R 800R	V
$I_T (RMS)$	RMS on-state current (full sine wave)	8	A
I_{TSM}	Non-repetitive peak on-state current (full cycle, T_j initial=25°C)	75	A

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
Rth j-mb	Thermal resistance Junction to mounting base		-	-	2.0	K/W
Rth j-a	Thermal resistance Junction to am bient	Pcb(FR4)mounted; footprint as in Fig.14	-	75	-	K/W

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Limiting values in accordance with the Maximum system(IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	UNIT
V_{DRM} V_{RRM}	Repetitive peak off-state Voltages	600R 800R	-	600 800	V
$I_{T(RMS)}$	RMS on-state current	all conduction angles	-	8	A
$I_{T(AV)}$	Average on-state current	Half sine wave; $\leq 111^{\circ}C$	-	5	A
I_{TSM}	Non-repetitive peak on-state current	half sine wave; $T_j = 25^{\circ}C$ prior to surge	-	75	A
I^2t	I^2t for fusing	$T = 10ms$ $t = 10ms$ $t = 8.3ms$	-	82	A
DI_T/dt	Repetitive rate of rise of on-state current after trigering	$T_{TM} = 10A$; $I_G = 50mA$; $D_{IG}/dt = 50mA/\mu s$	-	50	$A/\mu s$
I_{GM}	Peak gate current		-	2	A
V_{GM}	Peak gate voltage		-	5	V
P_{GM}	Peak gate power		-	5	W
$P_{G(AV)}$	Average gate power	Over any 20 ms period	-	0.5	W
T_{stg}	Storage temperature		-40	150	$^{\circ}C$
T_j	Operating junction Temperature		-	125^2	$^{\circ}C$

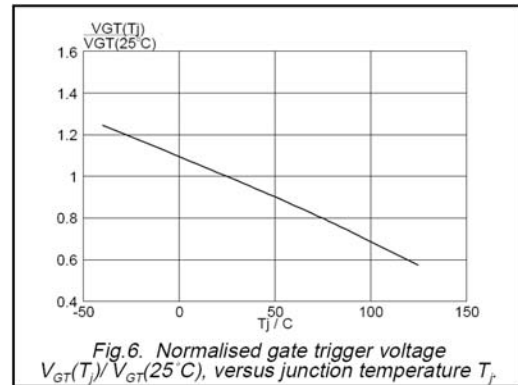
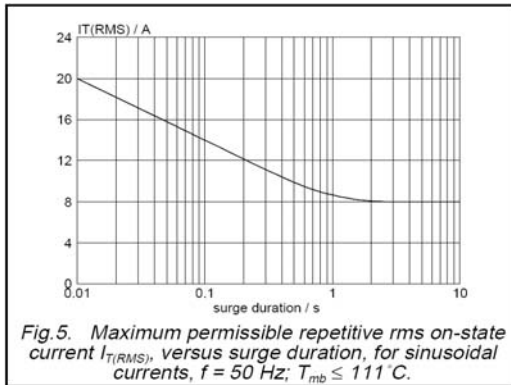
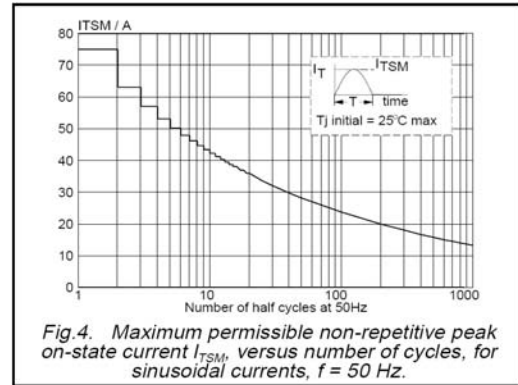
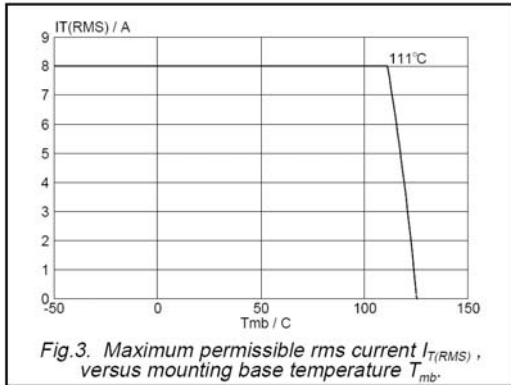
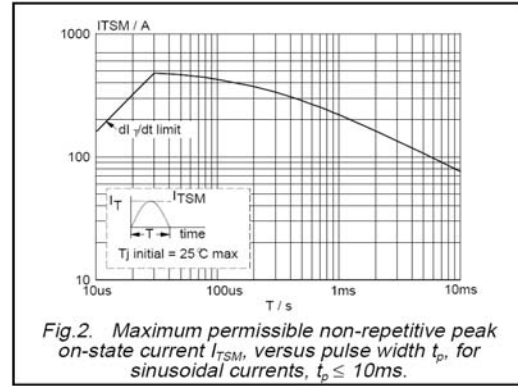
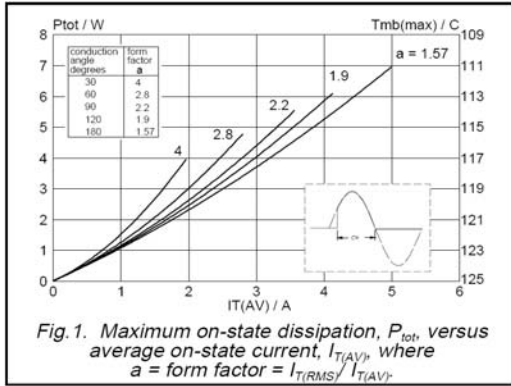
$T_j = 25^{\circ}C$ unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
Static characteristics						
I_{GT}	Gate trigger current	$V_D = 12V$; $I_T = 0.1A$	-	50	200	μA
I_L	Latching current	$V_D = 12V$; $I_{GT} = 0.1A$	-	0.4	10	mA
I_H	Holding current	$V_D = 12V$; $I_{GT} = 0.1A$	-	0.3	6	mA
V_T	On-state voltage	$I_T = 16A$	-	1.3	1.5	V
V_{GT}	Gate trigger voltage	$V_D = 12V$; $I_T = 0.1A$ $V_D = V_{DRM(max)}$; $I_T = 0.1A$; $T_j = 110^{\circ}C$	0.1	0.4 0.2	1.5 -	V V
I_D I_R	Off-state leakage current	$V_D = V_{DRM(max)}$; $V_R = V_{RRM(max)}$; $T_j = 125^{\circ}C$	-	0.1	0.5	mA

Dynamic Characteristics

D_{VD}/dt	Critical rate of rise of Off-state voltage	$V_{DM} = 67\% V_{DRM(max)}$; $T_j = 125^{\circ}C$; Exponential wave form; $R_{GK} = 100\Omega$	50	100	-	$V/\mu s$
t_{gt}	Gate controlled turn-on time	$I_{TM} = 10A$; $V_D = V_{DRM(max)}$; $I_G = 5mA$; $DI_G/dt = 0.2A/\mu s$	-	2	-	μs
t_g	Crcuit commutated tum-off time	$V_{DM} = 67\% V_{DRM(max)}$; $T_j = 125^{\circ}C$; $I_{TM} = 12A$ $V_R = 24V$; $dI_{TM}/dt = 10A/\mu s$ $dV_D/dt = 2V/\mu s$; $R_{GK} = 1k\Omega$	-	100	-	μs

Description



Description

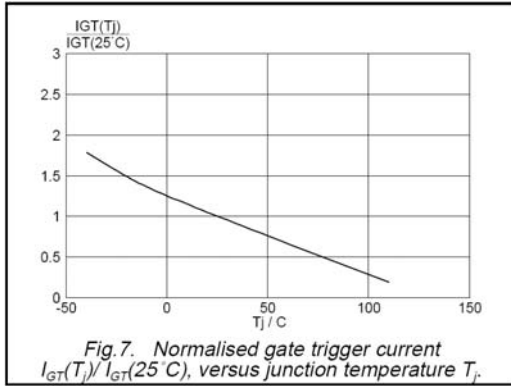


Fig. 7. Normalised gate trigger current $I_{GT}(T_j) / I_{GT}(25^\circ\text{C})$, versus junction temperature T_j .

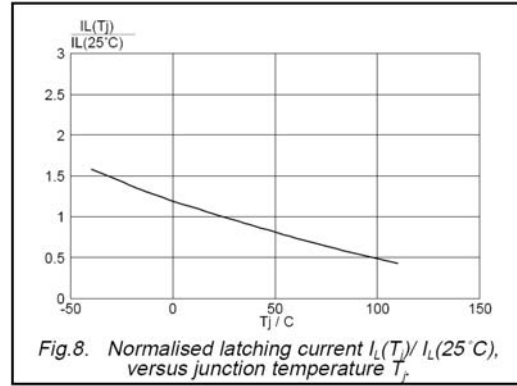


Fig. 8. Normalised latching current $I_L(T_j) / I_L(25^\circ\text{C})$, versus junction temperature T_j .

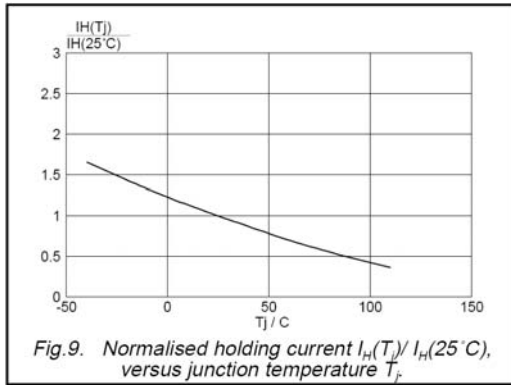


Fig. 9. Normalised holding current $I_H(T_j) / I_H(25^\circ\text{C})$, versus junction temperature T_j .

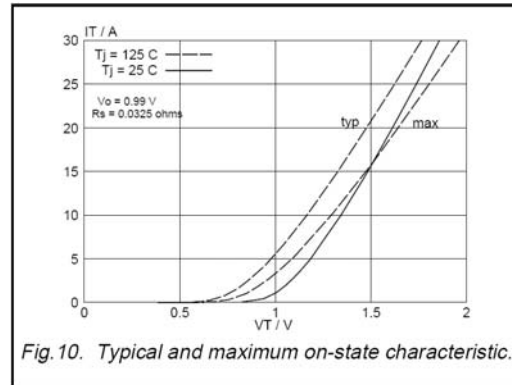


Fig. 10. Typical and maximum on-state characteristic.

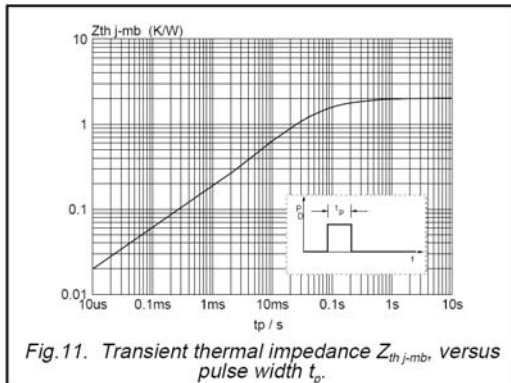


Fig. 11. Transient thermal impedance $Z_{th(j-mb)}$ versus pulse width t_p .

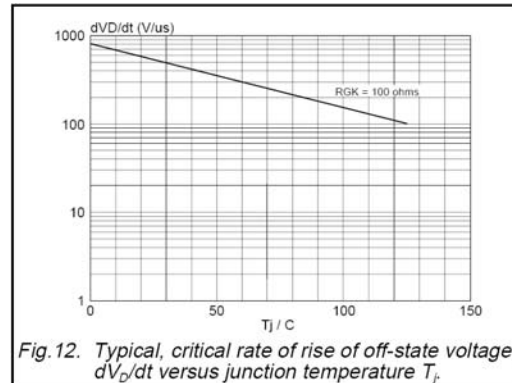


Fig. 12. Typical, critical rate of rise of off-state voltage, dV_D/dt versus junction temperature T_j .

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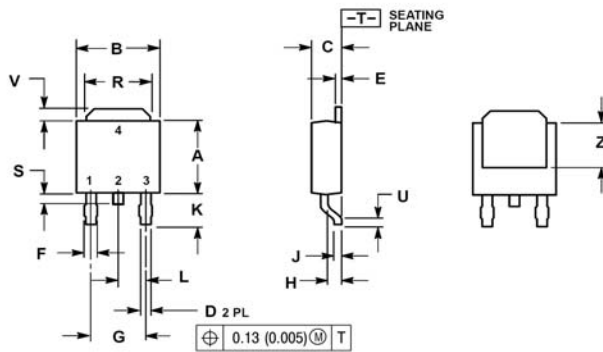
MECHANICAL DATA

Dimensions in mm

Net Mass: 0.45g

TO-252(DPAK)

DPAK
CASE 369C
ISSUE O



NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.235	0.245	5.97	6.22
B	0.250	0.265	6.35	6.73
C	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180 BSC		4.58 BSC	
H	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29 BSC	
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020	---	0.51	---
V	0.035	0.050	0.89	1.27
Z	0.155	---	3.93	---

STYLE 6:
PIN 1. MT1
2. MT2
3. GATE
4. MT2

SOLDERING FOOTPRINT*

